

Notice of References Cited

Application/Control No.

10/574,571

Applicant(s)/Patent Under
Reexamination
SANO ET AL.

Examiner

SEAHVOSH J. NIKMANESH

Art Unit

2812

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,399,208	06-2002	Baum et al.	428/446
*	B	US-2004/0188778	09-2004	Aoyama, Tomonori	257/410
*	C	US-6,884,719	04-2005	Chang et al.	438/681
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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